

RoHS Compliant Product  
A suffix of "-C" specifies halogen free

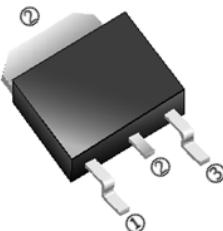
## DESCRIPTION

The SSD95N03-C is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent R<sub>DS(ON)</sub> and gate charge for most of the synchronous buck converter applications.

## FEATURES

- Advanced High Cell Density Trench Technology
- Super Low Gate Charge
- Excellent CdV/dt Effect Decline
- 100% EAS Guaranteed
- Green Device Available

**TO-252(D-Pack)**

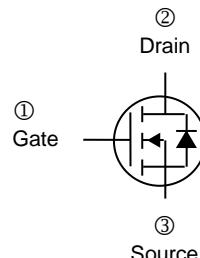


## MARKING



## PACKAGE INFORMATION

Package	MPQ	Leader Size
TO-252	2.5K	13 inch



## ORDER INFORMATION

Part Number	Type
SSD95N03-C	Lead (Pb)-free and Halogen-free

## ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub>=25°C unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V <sub>DS</sub>	30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current <sup>1</sup> @ V <sub>GS</sub> =10V	T <sub>C</sub> =25°C	96	A
	T <sub>C</sub> =100°C	88	A
Pulsed Drain Current <sup>2</sup>	I <sub>DM</sub>	192	A
Total Power Dissipation <sup>4</sup>	T <sub>C</sub> =25°C	P <sub>D</sub>	W
Linear Derating Factor		0.42	W/°C
Single Pulse Avalanche Energy <sup>3</sup>	E <sub>AS</sub>	317	mJ
Single Pulse Avalanche Current	I <sub>AS</sub>	53.8	A
Operating Junction & Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55~175	°C
Thermal Resistance Rating			
Maximum Thermal Resistance Junction-Ambient <sup>1</sup>	R <sub>θJA</sub>	62	°C/W
Maximum Thermal Resistance Junction-Case <sup>1</sup>	R <sub>θJC</sub>	2.4	

**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	30	-	-	V	$\text{V}_{\text{GS}}=0$ , $\text{I}_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	-	0.0213	-	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $\text{I}_D=1\text{mA}$
Gate-Threshold Voltage	$\text{V}_{\text{GS(th)}}$	1.0	-	2.5	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}$ , $\text{I}_D=250\mu\text{A}$
Forward Transconductance	$\text{g}_{\text{fs}}$	-	26.5	-	S	$\text{V}_{\text{DS}}=5\text{V}$ , $\text{I}_D=30\text{A}$
Gate-Source Leakage Current	$\text{I}_{\text{GSS}}$	-	-	$\pm 100$	nA	$\text{V}_{\text{GS}}= \pm 20\text{V}$
Drain-Source Leakage Current	$\text{I}_{\text{DSS}}$	$T_J=25^\circ\text{C}$	-	1	$\mu\text{A}$	$\text{V}_{\text{DS}}=24\text{V}$ , $\text{V}_{\text{GS}}=0$
			-	5		
Static Drain-Source On-Resistance <sup>2</sup>	$\text{R}_{\text{DS(ON)}}$	-	3.4	4	$\text{m}\Omega$	$\text{V}_{\text{GS}}=10\text{V}$ , $\text{I}_D=30\text{A}$
		-	5.2	6		$\text{V}_{\text{GS}}=4.5\text{V}$ , $\text{I}_D=15\text{A}$
Total Gate Charge	$\text{Q}_g$	-	31.6	-	$\text{nC}$	$\text{I}_D=15\text{A}$ $\text{V}_{\text{DS}}=15\text{V}$ $\text{V}_{\text{GS}}=4.5\text{V}$
Gate-Source Charge	$\text{Q}_{\text{gs}}$	-	8.6	-		
Gate-Drain ("Miller") Change	$\text{Q}_{\text{gd}}$	-	11.7	-		
Turn-on Delay Time	$\text{T}_{\text{d(on)}}$	-	9	-	$\text{nS}$	$\text{V}_{\text{DD}}=15\text{V}$ $\text{I}_D=15\text{A}$ $\text{V}_{\text{GS}}=10\text{V}$ $\text{R}_G=3.3\Omega$
Rise Time	$\text{T}_r$	-	19	-		
Turn-off Delay Time	$\text{T}_{\text{d(off)}}$	-	58	-		
Fall Time	$\text{T}_f$	-	15.2	-		
Input Capacitance	$\text{C}_{\text{iss}}$	-	3075	4000	$\text{pF}$	$\text{V}_{\text{GS}}=0$ $\text{V}_{\text{DS}}=15\text{V}$ $f=1\text{MHz}$
Output Capacitance	$\text{C}_{\text{oss}}$	-	400	530		
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$	-	315	-		
<b>Guaranteed Avalanche Characteristics</b>						
Single Pulse Avalanche Energy <sup>5</sup>	EAS	98	-	-	$\text{mJ}$	$\text{V}_{\text{DD}}=25\text{V}$ , $\text{L}=0.1\text{mH}$ , $\text{I}_{\text{AS}}=30\text{A}$
<b>Source-Drain Diode</b>						
Diode Forward Voltage <sup>2</sup>	$\text{V}_{\text{SD}}$	-	-	1.2	V	$\text{I}_S=30\text{A}$ , $\text{V}_{\text{GS}}=0$
Continuous Source Current <sup>1,6</sup>	$\text{I}_S$	-	-	96	A	$\text{V}_D=\text{V}_G=0$ , Force Current
Pulsed Source Current <sup>2,6</sup>	$\text{I}_{\text{SM}}$	-	-	192	A	

Notes:

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2oz copper.
2. The data tested by pulsed, pulse width $\leq 300\mu\text{s}$ , duty cycle $\leq 2\%$ .
3. The E<sub>AS</sub> data shows Max. rating. The test condition is  $\text{V}_{\text{DD}}=25\text{V}$ ,  $\text{V}_{\text{GS}}=10\text{V}$ ,  $\text{L}=0.1\text{mH}$ ,  $\text{I}_{\text{AS}}=53.8\text{A}$ .
4. The power dissipation is limited by  $175^\circ\text{C}$  junction temperature.
5. The Min. value is 100% E<sub>AS</sub> tested guarantee.
6. The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.

## CHARACTERISTIC CURVES

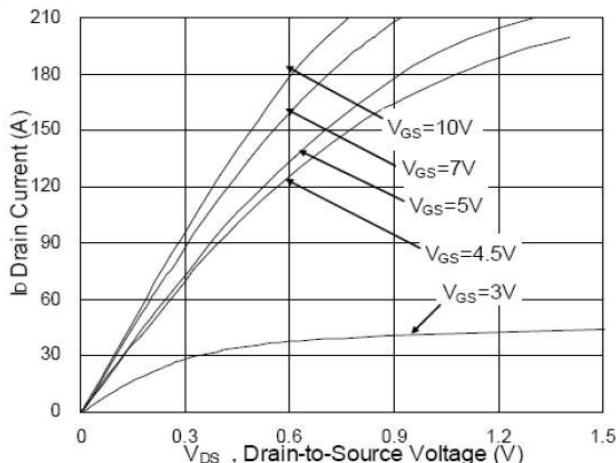


Fig.1 Typical Output Characteristics

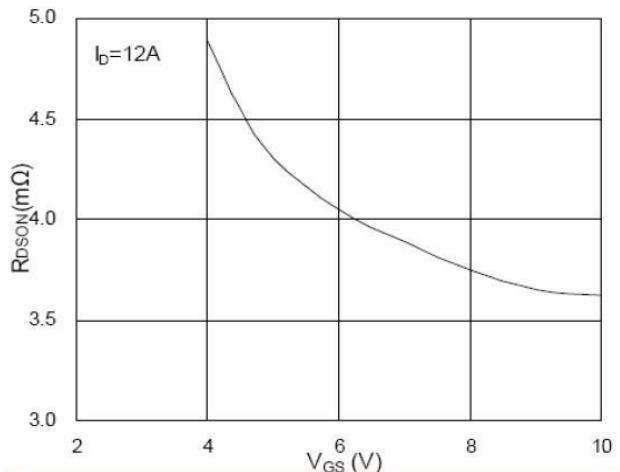


Fig.2 On-Resistance vs. G-S Voltage

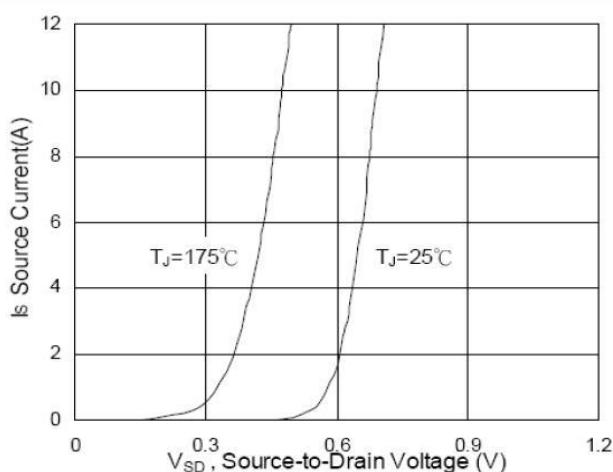


Fig.3 Forward Characteristics of Reverse

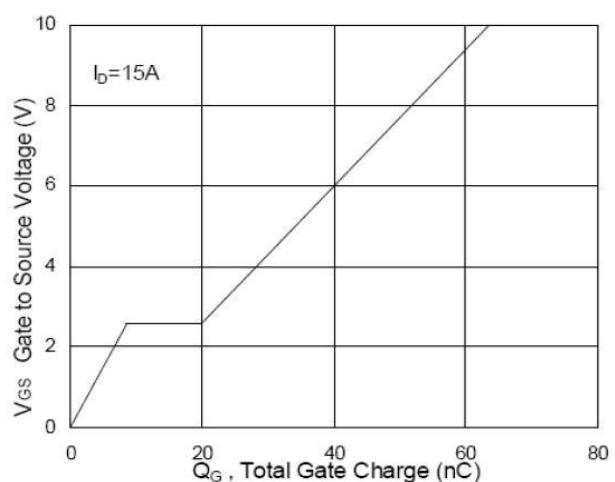


Fig.4 Gate-Charge Characteristics

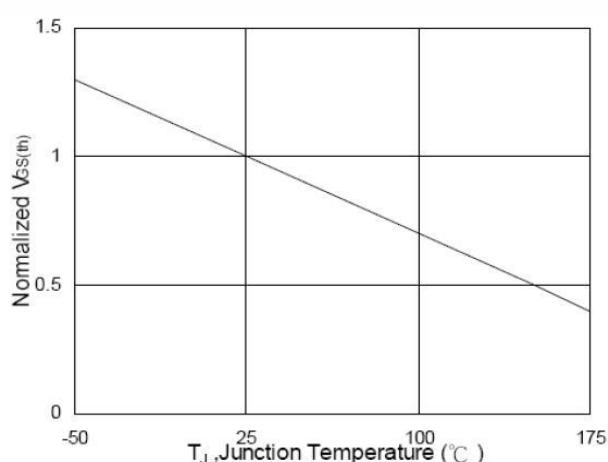


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$

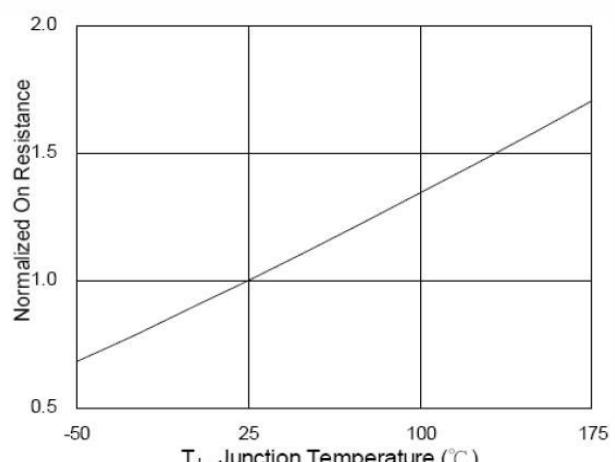


Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$

## CHARACTERISTIC CURVES

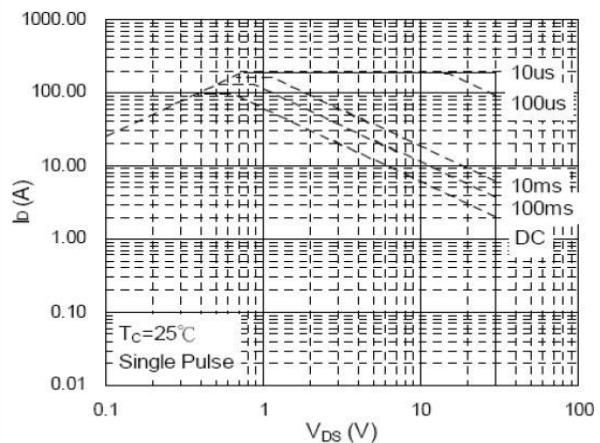
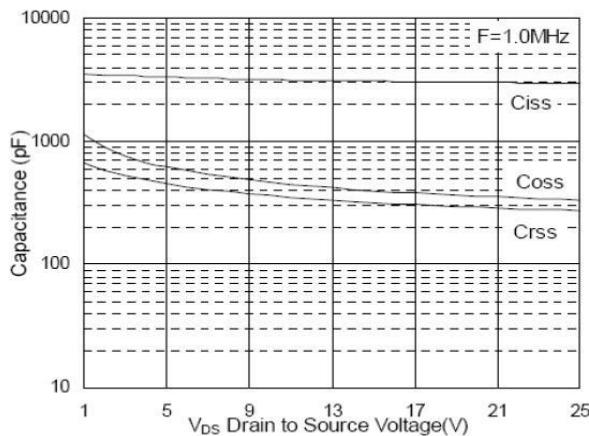


Fig.7 Capacitance

Fig.8 Safe Operating Area

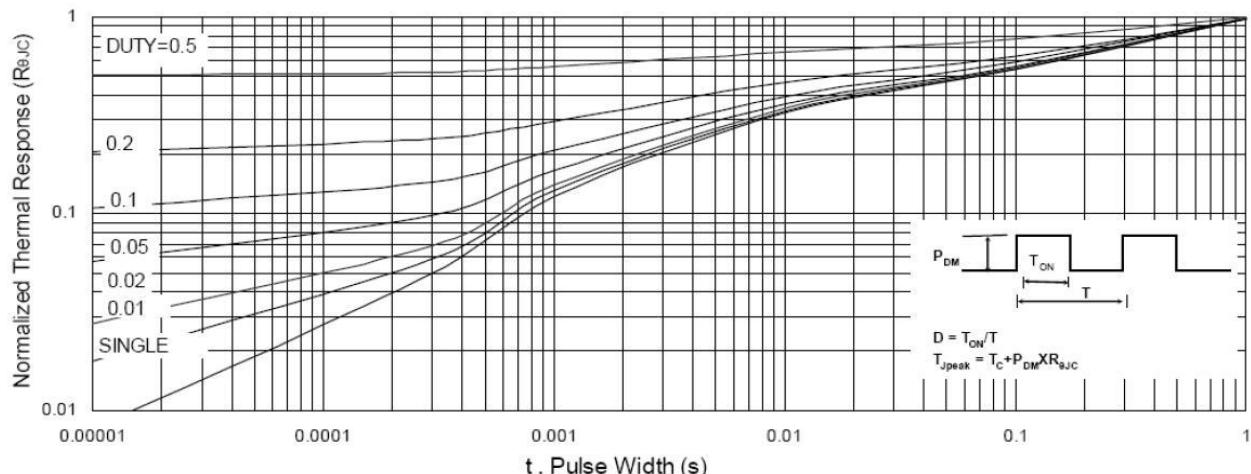


Fig.9 Normalized Maximum Transient Thermal Impedance

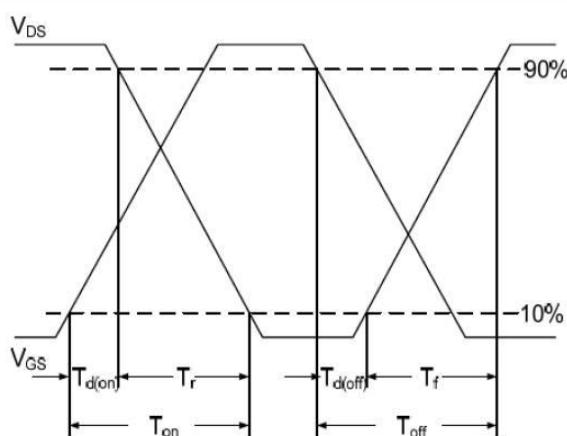


Fig.10 Switching Time Waveform

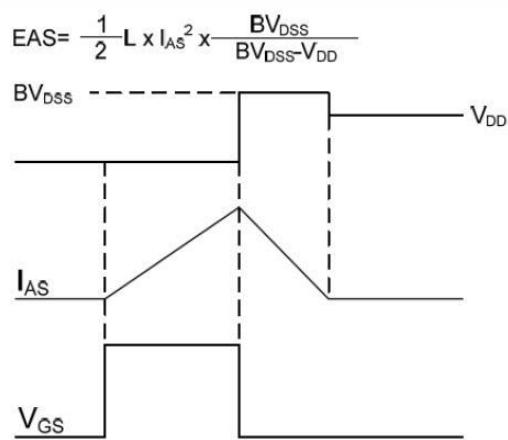
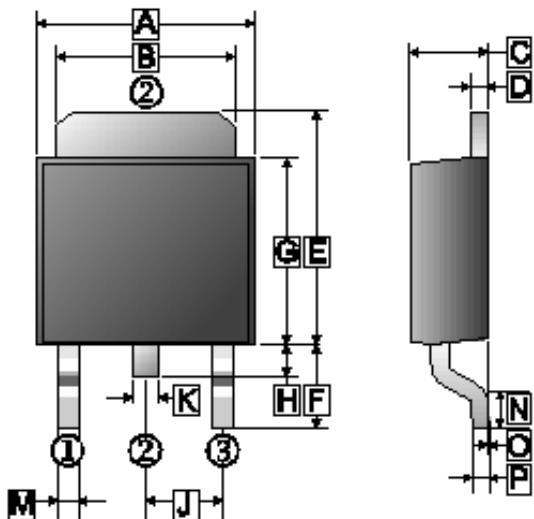


Fig.11 Unclamped Inductive Switching Wave

## PACKAGE OUTLINE DIMENSIONS

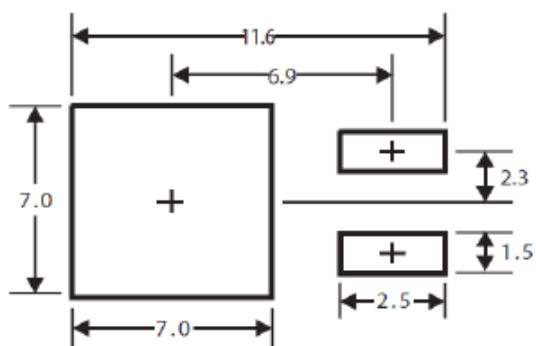
TO-252



REF.	Millimeter	
	Min.	Max.
A	6.30	6.90
B	4.95	5.53
C	2.10	2.50
D	0.40	0.90
E	6.00	7.70
F	2.90	REF.
G	5.40	6.40
H	0.60	1.20
J	2.30	REF.
K	0.89	REF.
M	0.45	1.14
N	1.55	TYP.
O	0	0.15
P	0.58	REF.

## MOUNTING PAD LAYOUT

TO-252



\*Dimensions in millimeters